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## N-Channel FREDFET

Power MOS $8^{\prime "}$ is a high speed, high voltage N -channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced trr, soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of $\mathrm{C}_{\mathrm{rss}} / \mathrm{C}_{\text {iss }}$ result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.


APT4F120K
Single die FREDFET


## FEATURES

- Fast switching with low EMI
- Low $\mathrm{t}_{\mathrm{rr}}$ for high reliability
- Ultra low $\mathrm{C}_{\text {rss }}$ for improved noise immunity
- Low gate charge
- Avalanche energy rated
- RoHS compliant


## TYPICAL APPLICATIONS

- ZVS phase shifted and other full bridge
- Half bridge
- PFC and other boost converter
- Buck converter
- Single and two switch forward
- Flyback


## Absolute Maximum Ratings

| Symbol | Parameter | Ratings | Unit |
| :---: | :--- | :---: | :---: |
| $I_{D}$ | Continuous Drain Current $@ T_{C}=25^{\circ} \mathrm{C}$ | 4 |  |
|  | Continuous Drain Current $@ T_{C}=100^{\circ} \mathrm{C}$ | 3 | A |
| $\mathrm{I}_{\mathrm{DM}}$ | Pulsed Drain Current ${ }^{(1)}$ | 15 |  |
| $\mathrm{~V}_{\text {GS }}$ | Gate - Source Voltage | $\pm 30$ | V |
| $\mathrm{E}_{\text {AS }}$ | Single Pulse Avalanche Energy ${ }^{(2)}$ | 310 | mJ |
| $\mathrm{I}_{\text {AR }}$ | Avalanche Current, Repetitive or Non-Repetitive | 2 | A |

## Thermal and Mechanical Characteristics

| Symbol | Characteristic | Min | Typ | Max | Unit |
| :---: | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{P}_{\mathrm{D}}$ | Total Power Dissipation @ $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | - | - | 225 | W |
| $\mathrm{R}_{\text {өJC }}$ | Junction to Case Thermal Resistance | - | - | .56 | $\mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\text {өСs }}$ | Case to Sink Thermal Resistance, Flat, Greased Surface | - | .11 | - |  |
| $\mathrm{T}_{J}, \mathrm{~T}_{\text {STG }}$ | Operating and Storage Junction Temperature Range | -55 | - | 150 | C |
| $\mathrm{T}_{\mathrm{L}}$ | Soldering Temperature for 10 Seconds (1.6mm from case) | - | - | 300 |  |
| $\mathrm{~W}_{T}$ | Package Weight | - | 0.07 | - | oz |
| Torque | Mounting Torque (TO-220 Package), 4-40 or M3 screw | - | 1.22 | - | g |

Static Characteristics
$\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise specified
APT4F120K

| Symbol | Parameter | Test Conditions |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {BR(DSS) }}$ | Drain-Source Breakdown Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  | 1200 |  |  | V |
| $\Delta \mathrm{V}_{\mathrm{BR}(\mathrm{DSS})} / \Delta \mathrm{T}_{\mathrm{J}}$ | Breakdown Voltage Temperature Coefficient | Reference to $25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  |  | 1.41 |  | $\mathrm{V} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{R}_{\text {DS(on) }}$ | Drain-Source On Resistance (3) | $V_{G S}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2 \mathrm{~A}$ |  |  | 3.42 | 4.2 | $\Omega$ |
| $\mathrm{V}_{\text {GS(th) }}$ | Gate-Source Threshold Voltage | $\mathrm{V}_{G S}=\mathrm{V}_{\text {DS }}, \mathrm{I}_{\mathrm{D}}=0.5 \mathrm{~mA}$ |  | 2.5 | 4 | 5 | V |
| $\Delta \mathrm{V}_{\mathrm{GS}(\mathrm{th})} / \Delta \mathrm{T}_{\mathrm{J}}$ | Threshold Voltage Temperature Coefficient |  |  |  | -10 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{I}_{\text {DS }}$ | Zero Gate Voltage Drain Current | $\begin{gathered} V_{D S}=1200 \mathrm{~V} \\ V_{G S}=0 \mathrm{~V} \end{gathered}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  |  | 250 | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  |  | 1000 |  |
| $\mathrm{I}_{\text {GSS }}$ | Gate-Source Leakage Current | $\mathrm{V}_{G S}= \pm 30 \mathrm{~V}$ |  |  |  | $\pm 100$ | nA |

Dynamic Characteristics
$\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise specified

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{g}_{\mathrm{fs}}$ | Forward Transconductance | $V_{D S}=50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=2 \mathrm{~A}$ |  | 4.5 |  | S |
| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\begin{gathered} V_{G S}=0 V, V_{D S}=25 V \\ f=1 M H z \end{gathered}$ |  | 1385 |  | pF |
| $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  |  | 17 |  |  |
| $\mathrm{C}_{\text {oss }}$ | Output Capacitance |  |  | 100 |  |  |
| $\mathrm{Co}_{\mathrm{o} \text { (rr) }}{ }^{(4)}$ | Effective Output Capacitance, Charge Related | $\mathrm{V}_{\text {GS }}=0 \mathrm{~V}, \mathrm{~V}_{\text {DS }}=0 \mathrm{~V}$ to 800 V |  | 40 |  |  |
| $\mathrm{Co}_{\text {(er) }}{ }^{\text {(5) }}$ | Effective Output Capacitance, Energy Related |  |  | 20 |  |  |
| $Q_{g}$ | Total Gate Charge | $\begin{aligned} V_{G S}= & 0 \text { to } 10 \mathrm{~V}, I_{D}=2 \mathrm{~A}, \\ & V_{D S}=600 \mathrm{~V} \end{aligned}$ |  | 43 |  | $n C$ |
| $Q_{\text {gs }}$ | Gate-Source Charge |  |  | 7 |  |  |
| $Q_{\text {gd }}$ | Gate-Drain Charge |  |  | 20 |  |  |
| $\mathrm{t}_{\mathrm{d}(\text { On) }}$ | Turn-On Delay Time | Resistive Switching$\begin{gathered} V_{D D}=800 \mathrm{~V}, I_{D}=2 \mathrm{~A} \\ R_{G}=10 \Omega \text { © }, V_{G G}=15 \mathrm{~V} \end{gathered}$ |  | 7.4 |  | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Current Rise Time |  |  | 4.4 |  |  |
| $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | Turn-Off Delay Time |  |  | 24 |  |  |
| $\mathrm{t}_{\mathrm{f}}$ | Current Fall Time |  |  | 6.9 |  |  |

## Source-Drain Diode Characteristics

| Symbol | Parameter | Test Conditions |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {s }}$ | Continuous Source Current (Body Diode) | MOSFET symbol showing the integral reverse p-n junction diode (body diode) |  |  |  | 4 | A |
| $\mathrm{I}_{\text {SM }}$ | Pulsed Source Current (Body Diode) ${ }^{11}$ |  |  |  |  | 15 |  |
| $\mathrm{V}_{\text {SD }}$ | Diode Forward Voltage | $\mathrm{I}_{\mathrm{SD}}=2 \mathrm{~A}, \mathrm{~T}_{J}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |  | 0.8 | 1.3 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\begin{aligned} I_{S D} & =2 A(3), \\ \mathrm{di}_{\mathrm{SD}} / \mathrm{dt} & =100 \mathrm{~A} / \mu \mathrm{s}, \\ V_{D D} & =100 \mathrm{~V} \end{aligned}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  | 170 | 195 | nS |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | 330 | 400 |  |
| $Q_{r r}$ | Reverse Recovery Charge |  | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  | . 370 |  | $\mu \mathrm{C}$ |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | . 820 |  |  |
| $I_{\text {rrm }}$ | Reverse Recovery Current |  | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ |  | 4.90 |  | A |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | 5.40 |  |  |
| dv/dt | Peak Recovery dv/dt | $\begin{gathered} \mathrm{I}_{\mathrm{SD}} \leq 2 \mathrm{~A}, \mathrm{di} / \mathrm{dt} \leq 1000 \mathrm{~A} \mu \mathrm{~s}, \mathrm{~V}_{\mathrm{DD}}=800 \mathrm{~V}, \\ \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C} \end{gathered}$ |  |  |  | 20 | V/ns |

(1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
(2) Starting at $T_{J}=25^{\circ} \mathrm{C}, \mathrm{L}=155.0 \mathrm{mH}, \mathrm{R}_{\mathrm{G}}=25 \Omega, \mathrm{I}_{\mathrm{AS}}=2 \mathrm{~A}$.
(3) Pulse test: Pulse Width $<380 \mu \mathrm{~s}$, duty cycle $<2 \%$.
(4) $\mathrm{C}_{\mathrm{O}(\mathrm{cr})}$ is defined as a fixed capacitance with the same stored charge as $\mathrm{C}_{\text {oss }}$ with $\mathrm{V}_{\mathrm{DS}}=67 \%$ of $\mathrm{V}_{\text {(BRIDSS }}$
(5) $C_{o(r e r)}^{o(c r)}$ is defined as a fixed capacitance with the same stored energy as $C_{\text {oss }}$ with $V_{D S}=67 \%$ of $V_{\text {(BR) }}^{\text {(BR)DSs }}$. To calculate $C_{o(e r)}$ for any value of $\mathrm{V}_{\text {DS }}$ less than $\mathrm{V}_{\text {(BRIDSS, }}$ use this equation: $\mathrm{C}_{\text {o(er) }}=-8.32 \mathrm{E}-8 / \mathrm{V}_{\text {DS }}{ }^{\wedge} 2+3.49 \mathrm{E}-8 / \mathrm{V}_{\text {DS }}+1.30 \mathrm{E}-10$.
(6) $R_{G}$ is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)


Figure 1, Output Characteristics


Figure $3, R_{\text {DS(ON) }}$ vs Junction Temperature


Figure 5, Gain vs Drain Current



Figure 2, Output Characteristics


Figure 4, Transfer Characteristics


Figure 6, Capacitance vs Drain-to-Source Voltage


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage



Figure 10, Maximum Forward Safe Operating Area


Figure 11. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

## TO-220 (K) Package Outline

e3 100\% Sn Plated


